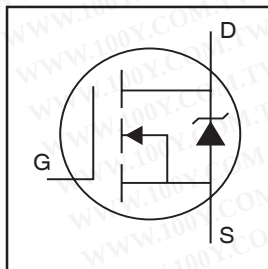


International IOR Rectifier

IRF3205PbF

HEXFET® Power MOSFET

- Advanced Process Technology
- Ultra Low On-Resistance
- Dynamic dv/dt Rating
- 175°C Operating Temperature
- Fast Switching
- Fully Avalanche Rated
- Lead-Free



$$V_{DS} = 55V$$

$$R_{DS(on)} = 8.0m\Omega$$

$$I_D = 110A^{\circ}$$

Description

Advanced HEXFET® Power MOSFETs from International Rectifier utilize advanced processing techniques to achieve extremely low on-resistance per silicon area. This benefit, combined with the fast switching speed and ruggedized device design that HEXFET power MOSFETs are well known for, provides the designer with an extremely efficient and reliable device for use in a wide variety of applications.

The TO-220 package is universally preferred for all commercial-industrial applications at power dissipation levels to approximately 50 watts. The low thermal resistance and low package cost of the TO-220 contribute to its wide acceptance throughout the industry.



TO-220AB

Absolute Maximum Ratings

	Parameter	Max.	Units
I_D @ $T_C = 25^{\circ}C$	Continuous Drain Current, V_{GS} @ 10V	110 ^⑤	A
I_D @ $T_C = 100^{\circ}C$	Continuous Drain Current, V_{GS} @ 10V	80	
I_{DM}	Pulsed Drain Current ^①	390	
P_D @ $T_C = 25^{\circ}C$	Power Dissipation	200	W
	Linear Derating Factor	1.3	W/°C
V_{GS}	Gate-to-Source Voltage	± 20	V
I_{AR}	Avalanche Current ^①	62	A
E_{AR}	Repetitive Avalanche Energy ^①	20	mJ
dv/dt	Peak Diode Recovery dv/dt ^③	5.0	V/ns
T_J T_{STG}	Operating Junction and Storage Temperature Range	-55 to + 175	°C
	Soldering Temperature, for 10 seconds	300 (1.6mm from case)	
	Mounting torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

Thermal Resistance

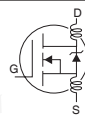
	Parameter	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case	—	0.75	°C/W
$R_{\theta CS}$	Case-to-Sink, Flat, Greased Surface	0.50	—	
$R_{\theta JA}$	Junction-to-Ambient	—	62	

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Electrical Characteristics @ $T_J = 25^\circ\text{C}$ (unless otherwise specified)

	Parameter	Min.	Typ.	Max.	Units	Conditions
$V_{(BR)DSS}$	Drain-to-Source Breakdown Voltage	55	—	—	V	$V_{GS} = 0V, I_D = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient	—	0.057	—	V/ $^\circ\text{C}$	Reference to $25^\circ\text{C}, I_D = 1mA$
$R_{DS(on)}$	Static Drain-to-Source On-Resistance	—	—	8.0	m Ω	$V_{GS} = 10V, I_D = 62A$ ④
$V_{GS(th)}$	Gate Threshold Voltage	2.0	—	4.0	V	$V_{DS} = V_{GS}, I_D = 250\mu A$
g_{fs}	Forward Transconductance	44	—	—	S	$V_{DS} = 25V, I_D = 62A$ ④
I_{DSS}	Drain-to-Source Leakage Current	—	—	25	μA	$V_{DS} = 55V, V_{GS} = 0V$
		—	—	250		$V_{DS} = 44V, V_{GS} = 0V, T_J = 150^\circ\text{C}$
I_{GSS}	Gate-to-Source Forward Leakage	—	—	100	nA	$V_{GS} = 20V$
	Gate-to-Source Reverse Leakage	—	—	-100		$V_{GS} = -20V$
Q_g	Total Gate Charge	—	—	146		$I_D = 62A$
Q_{gs}	Gate-to-Source Charge	—	—	35	nC	$V_{DS} = 44V$
Q_{gd}	Gate-to-Drain ("Miller") Charge	—	—	54		$V_{GS} = 10V$, See Fig. 6 and 13
$t_{d(on)}$	Turn-On Delay Time	—	14	—	ns	$V_{DD} = 28V$
t_r	Rise Time	—	101	—		$I_D = 62A$
$t_{d(off)}$	Turn-Off Delay Time	—	50	—		$R_G = 4.5\Omega$
t_f	Fall Time	—	65	—		$V_{GS} = 10V$, See Fig. 10 ④
L_D	Internal Drain Inductance	—	4.5	—	nH	Between lead, 6mm (0.25in.) from package and center of die contact
L_S	Internal Source Inductance	—	7.5	—		
C_{iss}	Input Capacitance	—	3247	—	pF	$V_{GS} = 0V$
C_{oss}	Output Capacitance	—	781	—		$V_{DS} = 25V$
C_{rss}	Reverse Transfer Capacitance	—	211	—		$f = 1.0MHz$, See Fig. 5
E_{AS}	Single Pulse Avalanche Energy ②	—	1050 ⑥	264 ⑦		$I_{AS} = 62A, L = 138\mu H$



Source-Drain Ratings and Characteristics

	Parameter	Min.	Typ.	Max.	Units	Conditions
I_S	Continuous Source Current (Body Diode)	—	—	110	A	MOSFET symbol showing the integral reverse p-n junction diode.
I_{SM}	Pulsed Source Current (Body Diode) ①	—	—	390		
V_{SD}	Diode Forward Voltage	—	—	1.3	V	$T_J = 25^\circ\text{C}, I_S = 62A, V_{GS} = 0V$ ④
t_{rr}	Reverse Recovery Time	—	69	104	ns	$T_J = 25^\circ\text{C}, I_F = 62A$
Q_{rr}	Reverse Recovery Charge	—	143	215	nC	$di/dt = 100A/\mu s$ ④
t_{on}	Forward Turn-On Time	Intrinsic turn-on time is negligible (turn-on is dominated by $L_S + L_D$)				

Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. (See fig. 11)
- ② Starting $T_J = 25^\circ\text{C}, L = 138\mu H$
 $R_G = 25\Omega, I_{AS} = 62A$. (See Figure 12)
- ③ $I_{SD} \leq 62A, di/dt \leq 207A/\mu s, V_{DD} \leq V_{(BR)DSS}, T_J \leq 175^\circ\text{C}$
- ④ Pulse width $\leq 400\mu s$; duty cycle $\leq 2\%$.
- ⑤ Calculated continuous current based on maximum allowable junction temperature. Package limitation current is 75A.
- ⑥ This is a typical value at device destruction and represents operation outside rated limits.
- ⑦ This is a calculated value limited to $T_J = 175^\circ\text{C}$.

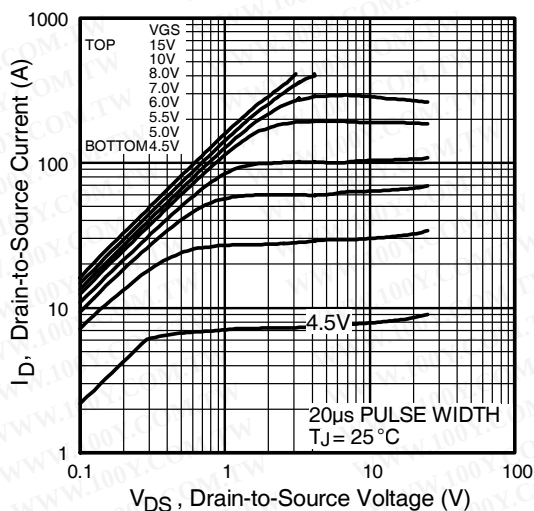


Fig 1. Typical Output Characteristics

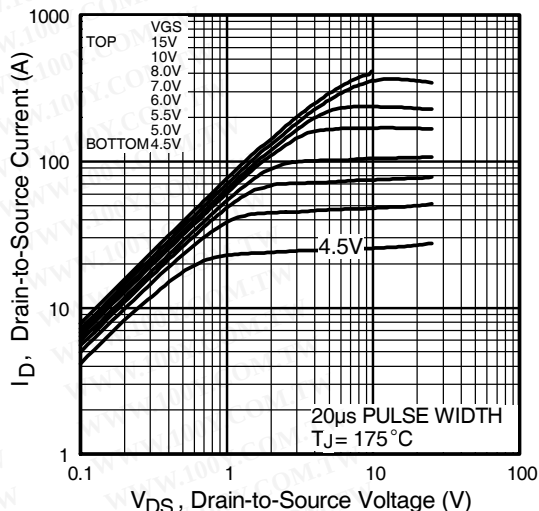


Fig 2. Typical Output Characteristics

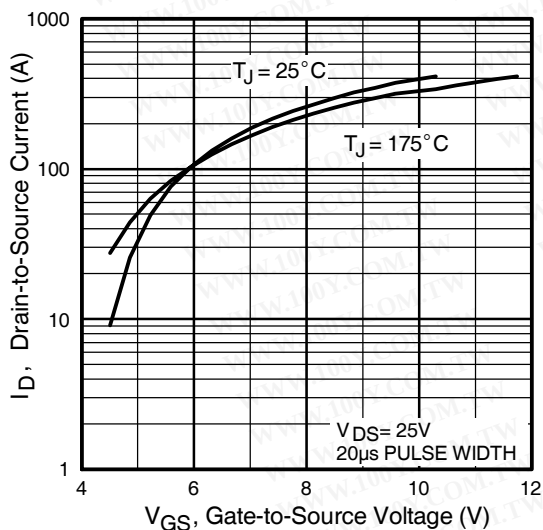


Fig 3. Typical Transfer Characteristics

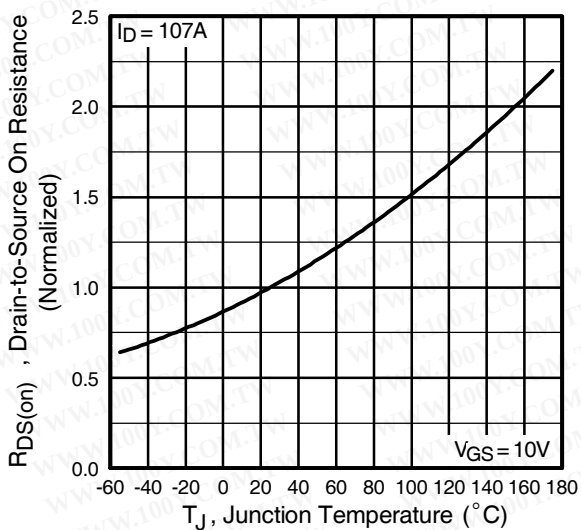


Fig 4. Normalized On-Resistance Vs. Temperature

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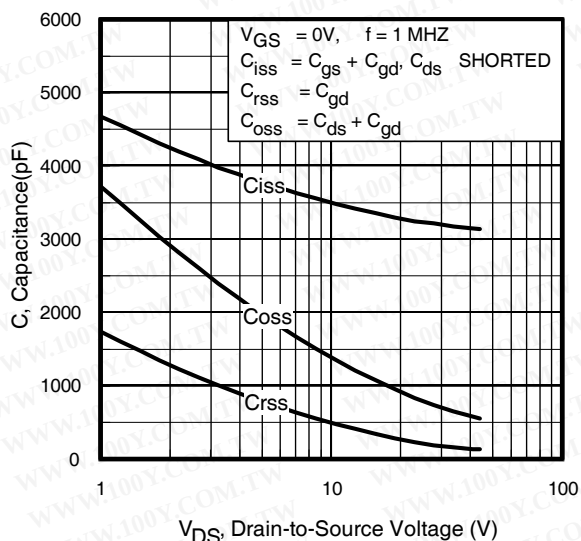


Fig 5. Typical Capacitance Vs.
 Drain-to-Source Voltage

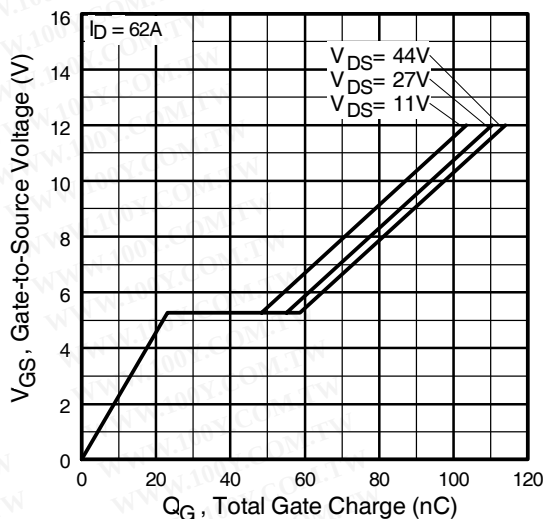


Fig 6. Typical Gate Charge Vs.
 Gate-to-Source Voltage

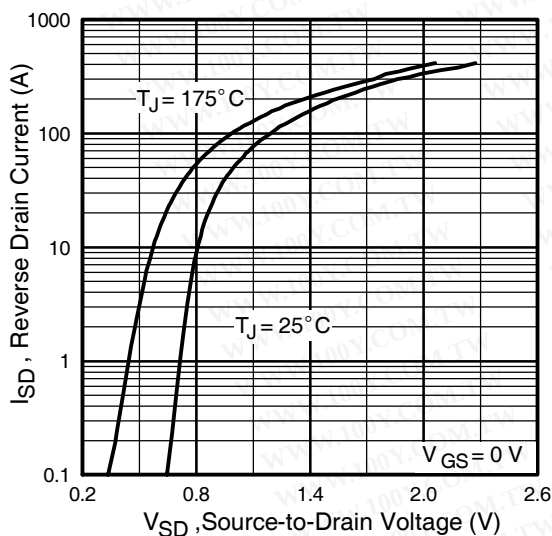


Fig 7. Typical Source-Drain Diode
 Forward Voltage

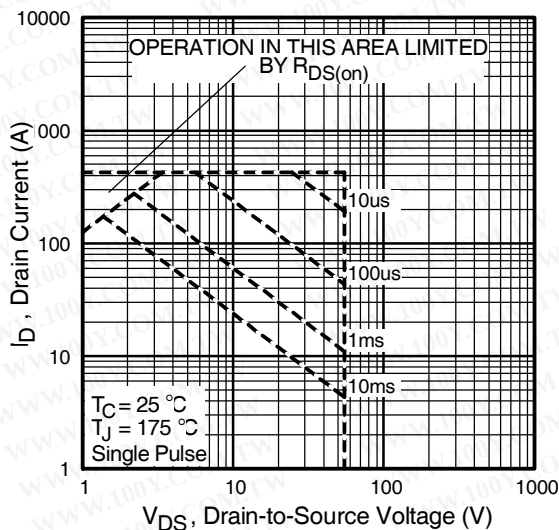


Fig 8. Maximum Safe Operating Area

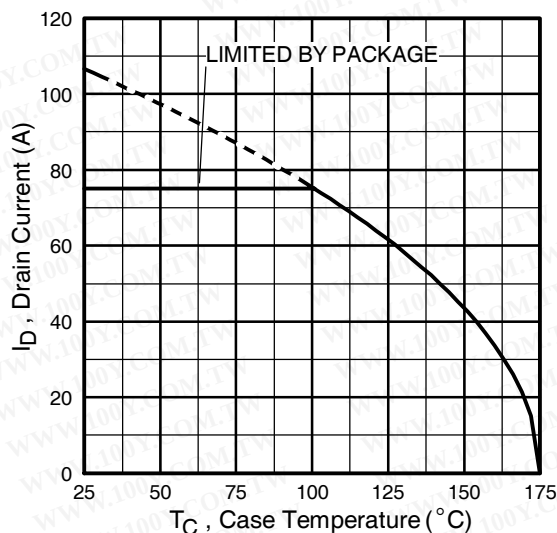


Fig 9. Maximum Drain Current Vs. Case Temperature

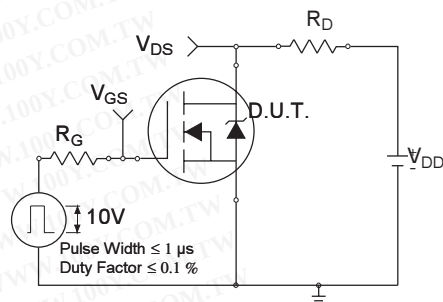


Fig 10a. Switching Time Test Circuit

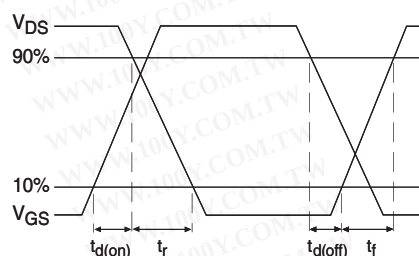


Fig 10b. Switching Time Waveforms

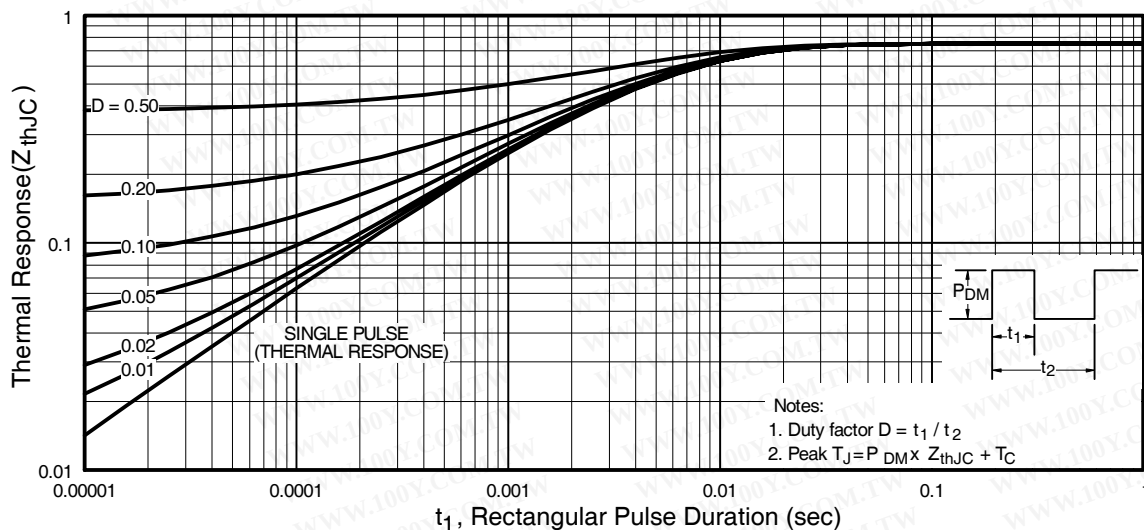


Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Case

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勝特力材料 886-3-5753170
 勝特力电子(上海) 86-21-34970699
 勝特力电子(深圳) 86-755-83298787
[Http://www.100y.com.tw](http://www.100y.com.tw)

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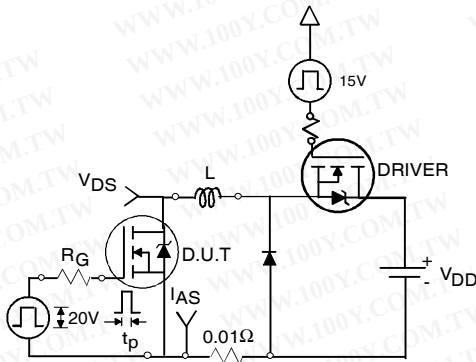


Fig 12a. Unclamped Inductive Test Circuit

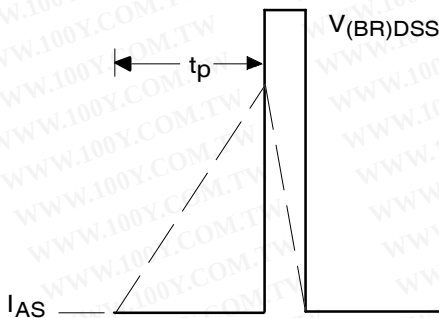


Fig 12b. Unclamped Inductive Waveforms

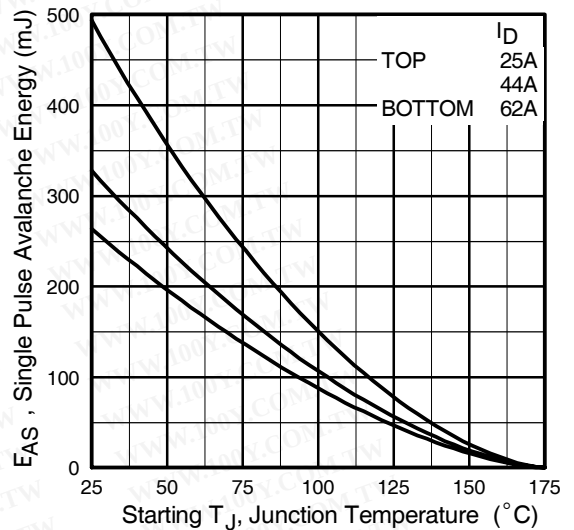


Fig 12c. Maximum Avalanche Energy Vs. Drain Current

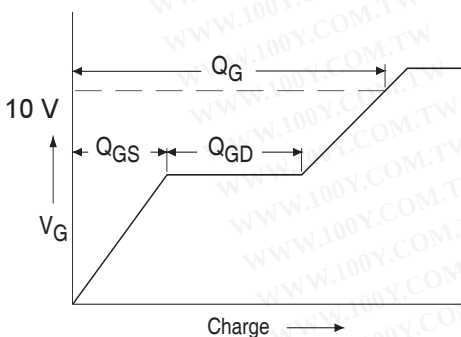


Fig 13a. Basic Gate Charge Waveform

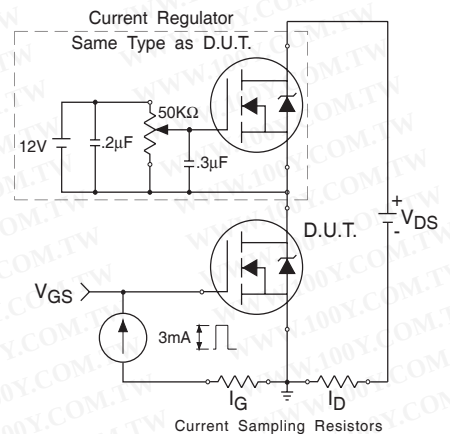
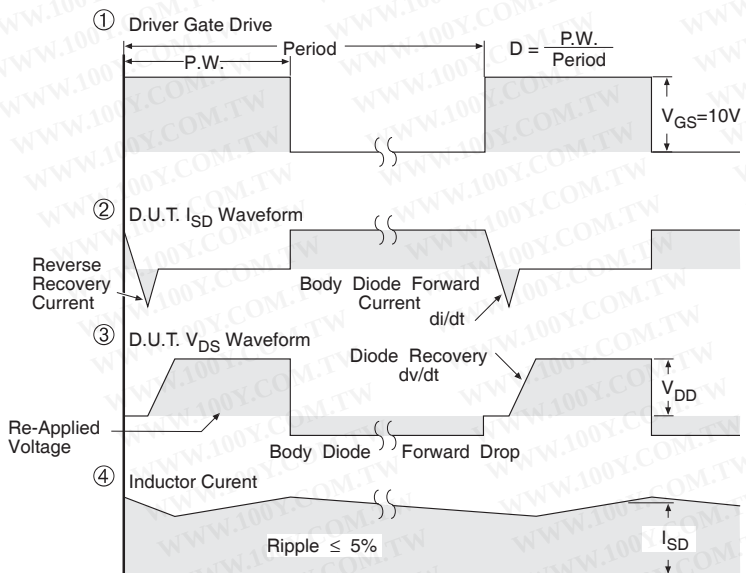
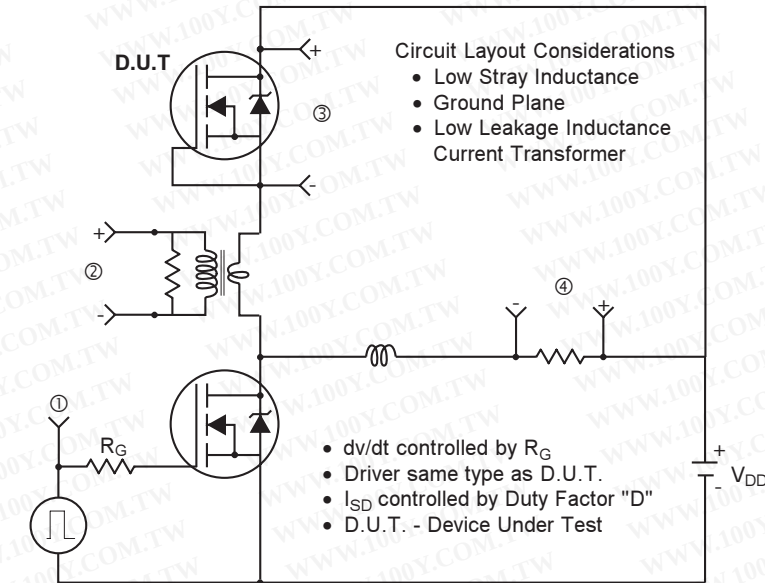


Fig 13b. Gate Charge Test Circuit

Peak Diode Recovery dv/dt Test Circuit



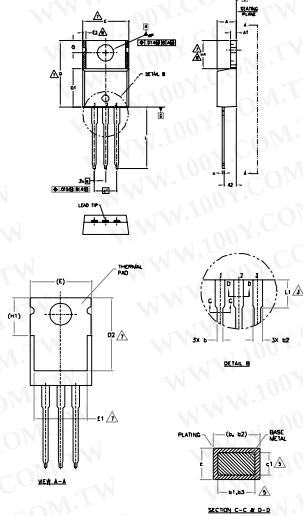
* $V_{GS} = 5V$ for Logic Level Devices

Fig 14. For N-Channel HEXFETS

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TO-220AB Package Outline

Dimensions are shown in millimeters (inches)



- NOTES:
1. DIMENSIONS AND TOLERANCES AS PER ASME Y14.5 M-1994
 2. DIMENSIONS ARE SHOWN IN MILLIMETERS (INCHES)
 3. LEAD DIMENSION AND PITCH UNCONTROLLED IN L1
 4. DIMENSION D, D1 & E DO NOT INCLUDE MOUNTING HOLE FLASH. THESE DIMENSIONS SHALL NOT EXCEED 0.05" (1.27) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY
 5. DIMENSION AT, AT1 & AT2 APPLY TO BASE METAL ONLY
 6. CONTROLLING DIMENSION: INCHES
 7. THERMAL PAD CENTER OPTIONAL WITHIN DIMENSIONS C1/C2 & T1
 8. DIMENSION C3 & C4 DEFINE A ZONE WHERE STRAPPING AND INSULATION IMPLIES ARE ALLOWED
 9. OUTLINE CONFORMS TO JEDEC TO-220, EXCEPT A2 (PINS) AND C2 (PINS). PINS DIMENSIONS ARE DERIVED FROM THE ACTUAL PACKAGE DRAWING

SYMBOL	DIMENSIONS				NOTES
	MILLIMETERS		INCHES		
	MIN.	MAX.	MIN.	MAX.	
A	3.56	4.83	.140	.190	
A1	0.91	1.40	.035	.055	
A2	2.03	2.92	.080	.115	
B	0.38	1.01	.015	.040	
B1	0.38	0.97	.015	.038	5
B2	1.14	1.78	.045	.070	
B3	1.14	1.73	.045	.068	5
C	0.38	0.61	.014	.024	
C1	0.38	0.36	.014	.022	5
D	14.22	16.51	.560	.650	4
D1	8.39	9.02	.330	.355	
D2	11.08	12.89	.440	.507	
E	8.65	10.67	.340	.420	4, 7
F	6.08	8.89	.270	.350	7
F3		0.76		.030	8
G	2.54	2.54	.100	.100	
H	2.54	2.54	.100	.100	
H1	5.84	6.86	.230	.270	7, 8
L	12.70	14.73	.500	.580	
L1	3.06	4.06	.120	.160	5
M	3.54	4.06	.139	.161	
Q	2.54	3.45	.100	.135	

USE ABREVIATIONS

1. GATE

2. DRAIN

3. SOURCE

4. CASE

5. THERMAL

6. PINS

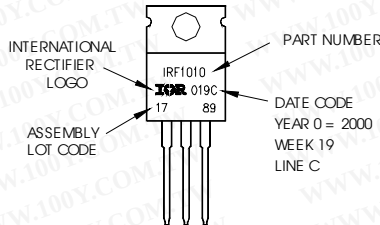
7. LEAD

8. PITCH

TO-220AB Part Marking Information

EXAMPLE: THIS IS AN IRF1010
 LOT CODE 1789
 ASSEMBLED ON WW 19, 2000
 IN THE ASSEMBLY LINE "C"

Note: "P" in assembly line position
 indicates "Lead-Free"



TO-220AB package is not recommended for Surface Mount Application

Data and specifications subject to change without notice.
 This product has been designed and qualified for the Industrial market.
 Qualification Standards can be found on IR's Web site.

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